International Rectifier

IRF5305PbF

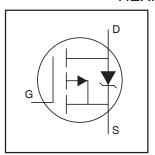
HEXFET® Power MOSFET

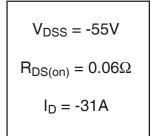
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated
- Lead-Free

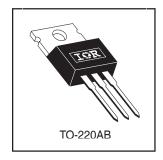
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.







Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ -10V	-31	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ -10V	-22	A
I _{DM}	Pulsed Drain Current ①	-110	
P _D @T _C = 25°C	Power Dissipation	110	W
	Linear Derating Factor	0.71	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy®	280	mJ
I _{AR}	Avalanche Current①	-16	A
E _{AR}	Repetitive Avalanche Energy①	11	mJ
dv/dt	Peak Diode Recovery dv/dt 3	-5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 srew	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		1.4	
R _{θCS}	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62	

10/31/03

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_D = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		-0.034		V/°C	Reference to 25°C, I _D = -1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.06	Ω	V _{GS} = -10V, I _D = -16A ④
V _{GS(th)}	Gate Threshold Voltage	-2.0		-4.0	٧	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
9 _{fs}	Forward Transconductance	8.0			S	$V_{DS} = -25V, I_{D} = -16A$
I	Drain-to-Source Leakage Current			-25	μА	$V_{DS} = -55V, V_{GS} = 0V$
I _{DSS}	Brain to Gource Leakage Guiterit			-250	μΑ	$V_{DS} = -44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
lass	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	IIA	V _{GS} = -20V
Qg	Total Gate Charge			63		I _D = -16A
Q _{gs}	Gate-to-Source Charge			13	nC	$V_{DS} = -44V$
Q _{gd}	Gate-to-Drain ("Miller") Charge			29		V_{GS} = -10V, See Fig. 6 and 13 \oplus
t _{d(on)}	Turn-On Delay Time		14			$V_{DD} = -28V$
t _r	Rise Time		66		, l	$I_D = -16A$
t _{d(off)}	Turn-Off Delay Time		39		ns	$R_G = 6.8\Omega$
t _f	Fall Time		63			$R_D = 1.6\Omega$, See Fig. 10 \oplus
1_	Internal Drain Inductance		4.5			Between lead,
L _D	Internal Dialit Inductance		4.5		- nH	6mm (0.25in.)
L _S	Internal Source Inductance		7.5			from package
						and center of die contact
C _{iss}	Input Capacitance		1200			$V_{GS} = 0V$
Coss	Output Capacitance		520		pF	$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance		250			f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions																	
Is	Continuous Source Current			-31		MOSFET symbol																	
	(Body Diode)			-31	Α	showing the																	
I _{SM}	Pulsed Source Current		110	110	110	110	110	440	110	110	110	110	110	110	110	110	110	110	110	110	110	^	integral reverse
	(Body Diode) ①				p-n junction diode.																		
V _{SD}	Diode Forward Voltage			-1.3	V	T _J = 25°C, I _S = -16A, V _{GS} = 0V ④																	
t _{rr}	Reverse Recovery Time		71	110	ns	$T_J = 25^{\circ}C$, $I_F = -16A$																	
Q _{rr}	Reverse RecoveryCharge		170	250	nC	di/dt = -100A/µs ④																	

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\begin{tabular}{ll} \mathbb{O} $V_{DD}=$-25V, starting $T_J=25^{\circ}C$, $L=2.1mH$ \\ $R_G=25\Omega$, $I_{AS}=$-16A. (See Figure 12) \\ \end{tabular}$
- $\label{eq:loss} \begin{array}{l} \text{ } 3 \text{ } I_{SD} \leq \text{-16A, di/dt} \leq \text{-280A/}\mu\text{s, } V_{DD} \leq V_{(BR)DSS}, \\ T_{J} \leq 175^{\circ}\text{C} \end{array}$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.

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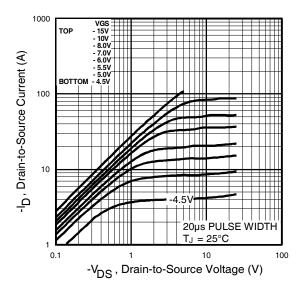


Fig 1. Typical Output Characteristics

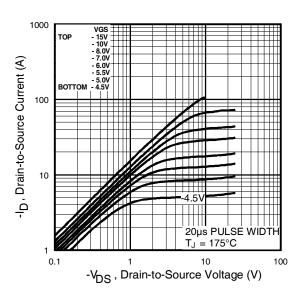


Fig 2. Typical Output Characteristics

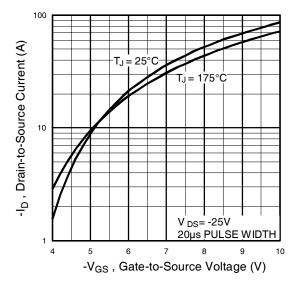


Fig 3. Typical Transfer Characteristics

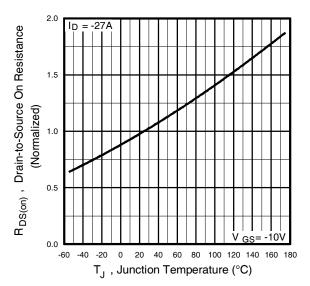


Fig 4. Normalized On-Resistance Vs. Temperature

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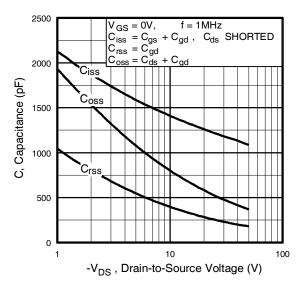


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

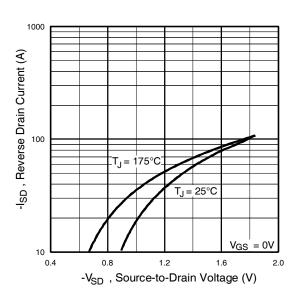


Fig 7. Typical Source-Drain Diode Forward Voltage

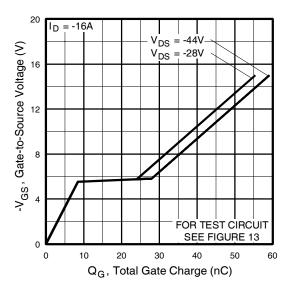


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

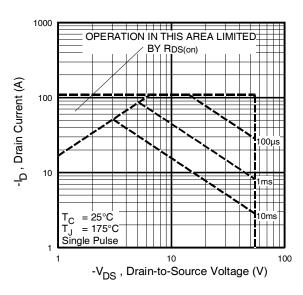
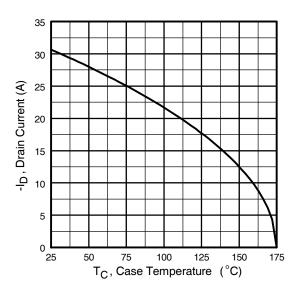


Fig 8. Maximum Safe Operating Area

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 V_{DS} V_{GS} V_{GS} D.U.T. V_{DD} V_{DS} V_{DS} V_{DD} V_{DS} V_{DD} V_{DD} V_{DS} V_{DD} V_{DD} V_{DD} V_{DS} V_{DD} V_{DD} V_{DS} V_{DD} V_{DD} V_{DD} V_{DS} V_{DS} V_{DD} V_{DS} V_{DS} V

Fig 10a. Switching Time Test Circuit

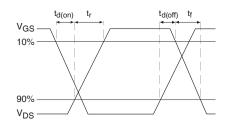


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10b. Switching Time Waveforms

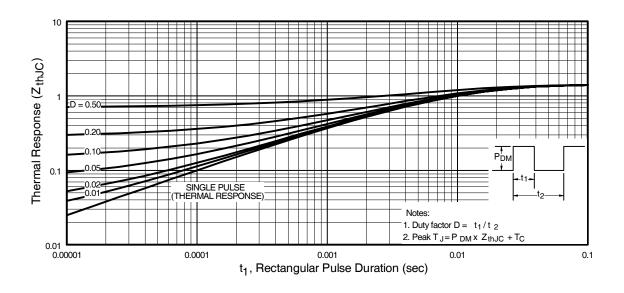


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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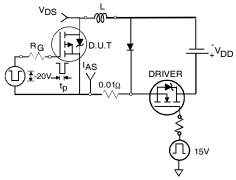


Fig 12a. Unclamped Inductive Test Circuit

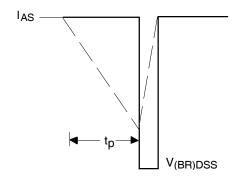


Fig 12b. Unclamped Inductive Waveforms

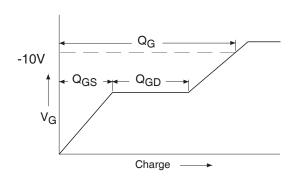


Fig 13a. Basic Gate Charge Waveform

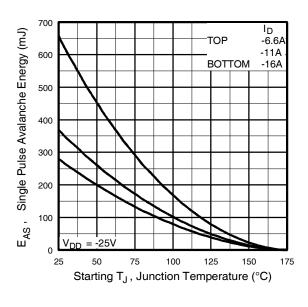


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

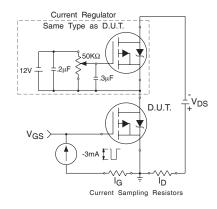
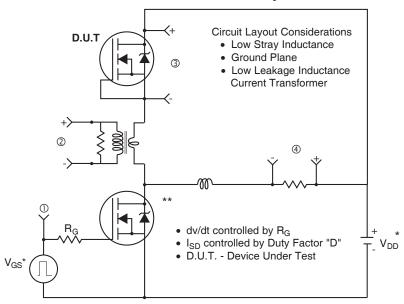
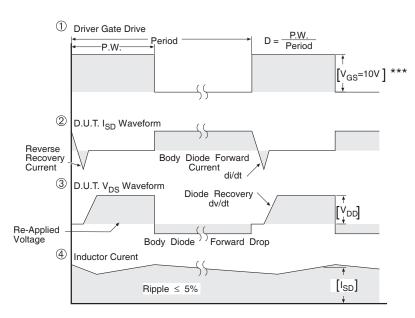


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



- * Reverse Polarity for P-Channel
- ** Use P-Channel Driver for P-Channel Measurements



*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

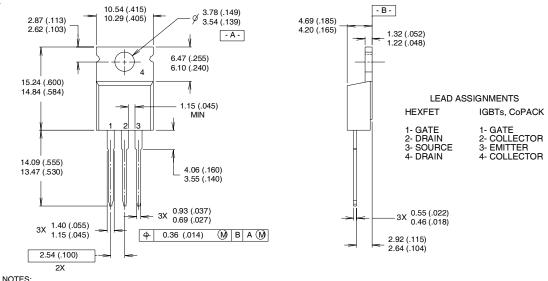
Fig 14. For P-Channel HEXFETS

International

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TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
 - 2 CONTROLLING DIMENSION : INCH
- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

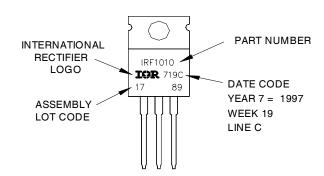
TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.



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Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/

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